

## REMARKS

In response to the new office action dated October 27, 2003, please enter the amendments set forth above and the following remarks.

Most of the pending art claims (i.e., claims 13, 15-33 and 38-44) stand rejected as being anticipated or obvious in view of the Lin reference. Others stand rejected as being anticipated or obvious in view of the Yamaguchi reference. These rejections are respectfully traversed. It is believed that neither Lin nor Yamaguchi disclose or reasonably suggest the various combinations set forth in the claims. As previously discussed, the various claims require various elements that are neither disclosed nor reasonably suggested by the art of record. Accordingly, it is respectfully submitted that the claims as presently presented are patentable over the art of record.

Given the somewhat extended and convoluted prosecution of this application, it is believed that it would be helpful to include a substitute specification that includes all of the amendments made to the present application to date. Additionally, the substitute specification includes a few additional cleanup amendments which are marked on the accompanying marked up version of the specification.

We are also enclosing substitute formal drawings. The substitute formal drawing incorporate the proposed drawing corrections previously submitted. Additionally, some of the component labeling on Figs. 1(a) and 1(b) has been further changed to improve the readability of the drawings. It is respectfully submitted that the amendments to the drawings do not contain any new matter.

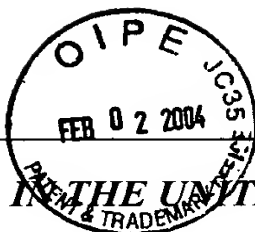
If the Examiner has any continuing concerns about the claim language or other aspects of this application, she is respectfully requested to contact the undersigned at the number set forth below.

Respectfully submitted,  
BEYER WEAVER & THOMAS, LLP



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PATENT

**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

In re application of: Mostafazadeh et al.

Application No.: 09/625,071

Filed: July 25, 2000

Title: LEAD FRAME CHIP SCALE PACKAGE

Attorney Docket No.:

NSC1P217D2/NS-3877-2

Examiner: Clark, S.

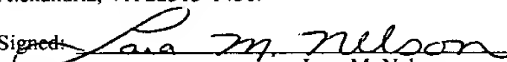
Group: 2815

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**CERTIFICATE OF MAILING**

I hereby certify that this correspondence is being deposited with the U.S. Postal Service with sufficient postage as first-class mail on January 27, 2004 in an envelope addressed to the Commissioner for Patents, P.O. Box 1450 Alexandria, VA 22313-1450.

Signed:

  
Lara M. Nelson

**SUBMISSION OF SUBSTITUTE SPECIFICATION**

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

Dear Sir:

Enclosed is a Substitute Specification for the originally filed specification in this application. This Substitute Specification is being voluntarily submitted, in order to facilitate the processing of the application. Also enclosed is a marked-up copy of the Substitute Specification showing the matter being added to and the matter being deleted from the specification.

Provided below is a statement as required by 37 CFR §1.125, that the Substitute Specification transmitted herewith contains no new matter.

**STATEMENT THAT THE SUBSTITUTE SPECIFICATION CONTAINS NO NEW MATTER (37 CFR §1.125)**

I hereby state that the accompanying Substitute Specification contains no new matter over that contained in the above-identified application originally filed. I further state that the changes made are the same as indicated in the interlineated Substitute Specification also accompanying this statement.

It is submitted, therefor, that the Substitute Specification should be accepted by the Examiner and entered into the file. If there are any questions regarding this matter, the Examiner is respectfully requested to telephone the undersigned.

Respectfully submitted,

BEYER WEAVER & THOMAS, LLP

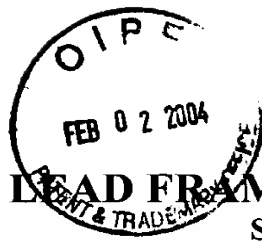


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**MARKED-UP VERSION OF SUBSTITUTE  
SPECIFICATION**



# LEAD FRAME CHIP SCALE PACKAGE

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## BACKGROUND INFORMATION

### 10 Field of the Invention

The present invention relates to integrated circuit packages, and more specifically, to the production of a chip scale integrated circuit package using a lead frame.

15

### Related Art

The use of a lead frame provides an inexpensive means for IC package manufacturing. Etching or stamping a sheet of thin metal to produce the desired lead frame patterns is a well-known manufacturing process, and is conducive to high-  
20 volume, low-cost production. In addition, the lead frame panel provides a support framework for the IC chips during IC package assembly. ~~However, as Figs. 1d-1 through 1d-3 show examples of common IC packages using lead frames. Fig. 1d-1 shows a small outline package (SOP) 191. Figure 1d-2 shows a pin-through hole (PTH) package 192. Figure 1d-3 shows a plastic leaded chip carrier (PLCC) 193.~~

25 As IC chip device densities increase and IC package sizes decrease, the geometries used in the electrical communication paths between the IC chip and the PCB decrease. For example, a chip scale package requires that the protective casing be no more than 20% larger than the IC chip. As a result, the area available for the electrical paths provided by the lead frame is significantly reduced, demanding much  
30 finer lead frame patterns. ~~In order to construct that finer geometry, the lead frame thickness must be reduced to a point where the lead frame panel rigidity would no longer be sufficient to provide the necessary support during the IC package assembly process. Also, the fragile lead frame patterns would be more susceptible to damage during the manufacturing process. As a result, chip scale IC packages must use more~~  
35 ~~costly techniques such as tape automated bonding (TAB) or printed substrate backing.~~ Accordingly, it is desirable to provide an IC packaging method that allows the use of a lead frame in a chip scale package.

## SUMMARY OF THE INVENTION

The present invention provides a method for producing chip scale IC packages using lead frames. ~~A temporary support fixture provides support and stability to a thin lead frame panel having the fine geometries required for high density IC chip interfaces. An embodiment of the support fixture includes an adhesive pad made of one-sided sticky tape mounted to a rigid frame made of stainless steel, the rigid frame maintaining the adhesive pad in a fixed configuration providing a stable flat surface for support of the lead frame panel. Alternatively, the rigid frame and adhesive pad can be made of any materials compatible with the IC package manufacturing process and capable of supporting the lead frame panel through the manufacturing process. The adhesive pad can also be patterned to ease the manufacturing process. The rigid frame can include positioning features to assist in the alignment of the lead frame and adhesive pad. If encapsulant material is to be dispensed over the lead frame panel, a containment dam can be formed around the lead frame after it is installed on the adhesive pad, to provide a boundary for encapsulant material flow.~~ In one aspect of the invention, a lead frame panel suitable for use in packaging an array of integrated circuits is described. The lead frame panel includes a matrix of tie bars that extend in substantially perpendicular rows and columns to define a two dimensional array of immediately adjacent device areas separated only by the tie bars. Each device area is suitable for use in an independent integrated circuit package and includes a die attach pad and a plurality of conductive contacts.

In another aspect of the invention, a panel assembly suitable for use in simultaneously packaging a multiplicity of integrated circuits is described. The panel assembly includes a lead frame panel formed from a conductive sheet. The lead frame panel is patterned to define at least one two dimensional array of adjacent device areas. Each device area is suitable for use as part of an independent integrated circuit package and including a die and a plurality of contacts positioned around and electrically connected to the die. A molded cap is also provided that substantially uniformly covers a two dimensional array of adjacent device areas while leaving bottom surfaces of the conductive contacts exposed to facilitate electrical connection to external components. The encapsulation material that forms the molded cap is

exposed at a bottom surface of the panel of integrated circuits to physically isolate the contacts.

## **BRIEF DESCRIPTION OF THE DRAWINGS**

5 Fig. 1a shows a representation of a ~~typical~~ lead frame panel in accordance with one embodiment of the present invention;

Fig. 1b shows [a] the lead frame panel of Fig. 1a populated with IC chips;

Figs. 1c-1 and 1c-2 ~~shows~~ show bottom and cross sectional views of a single leadframe BGA IC package in accordance with another embodiment of the present  
10 invention;

Figs. 1d-1 through 1d-3 ~~show~~ shows examples of common IC packages;

Fig. 2a shows an embodiment of a rigid support fixture;

Fig. 2b shows a lead frame panel mounted on an embodiment of a support  
fixture;

15 Figs. 3a and 3b show a flow diagram of a manufacturing process using a temporary support fixture.

Use of the same reference number in different figures indicates similar or like elements.

## **DETAILED DESCRIPTION**

20 Generally, an integrated circuit (IC) package encapsulates an IC chip, or die, in a protective casing and also provides power and signal distribution between the IC chip and an external printed circuit board (PCB). A metal lead frame can be used to provide the electrical paths for that distribution. A lead frame panel suitable for use in  
25 accordance with the present invention is illustrated in Fig. 1a. For production purposes, a lead frame panel 110 made up of multiple lead frames 120 is etched or stamped from a thin sheet of metal, as shown in Fig. 1a. An IC chip 130 is then mounted and wire bonded to each lead frame 120, as shown in Fig. 1b. Wire bonding is typically performed using fine gold wires 140. As illustrated in Fig. 1c, each IC  
30 chip 130 is then encapsulated in a protective casing 160 which may be formed by dispensing and molding a layer of encapsulant material over all IC chips 130. Next lead frames 120 are cut apart, or singulated to produce individual IC packages 190.

Referring again to Fig. 1a, panel 110 includes a two dimensional array of device areas. Each device area has a plurality of contacts 112 and a die attach pad 114. The panel has a grid of tie bars 115 that extend in perpendicular rows and columns to define the device areas. The tie bars 115 carry the contacts 112 and die attach pads 114.

The embodiment shown in Fig. 2a employs a rigid supporting fixture during the manufacturing process to enable the use of lead frames in chip scale IC packages. An embodiment of a support fixture 200 includes a rigid frame 210 and an adhesive pad 220, as shown in the exploded isometric diagram of Fig. 2a. Because pad 220 is affixed along its border to frame 210, it maintains sufficient tension to provide a stable supporting surface for a lead frame panel 110. By making pad 220 out of a thin, flexible, and electrically non-conductive material, it provides a support structure that will not interfere with the conventional manufacturing processes used in IC package assembly. The size of the interior opening of frame 210 is large enough to allow lead frame panel 110 to be fully supported by pad 220. Multiple IC chips 130 are then installed and wire bonded on lead frame panel 110, as shown in Fig. 2b. Subsequent encapsulation of IC chips 130 in protective casings proceeds as in conventional lead frame processing. If a molded protective casing is to be applied, an encapsulant dam 240 can be constructed around the perimeter of lead frame panel 110. Dam 240 can be made of any substantially rigid substance, including premolded plastic, epoxy, or tape, and serves to prevent flow of encapsulant material beyond the boundaries of lead frame panel 110. Alternatively, containing measures for encapsulant material could be incorporated into the dispensing mechanism. Once encapsulation is complete, support fixture 200 can be removed, either before or after singulation.

The embodiment of the present invention shown in Figs. 2a and 2b can be constructed from common and readily available materials. Pad 220 can be made from a 3M or Nitto-brand sticky tape used in conventional wafer saw operations. Likewise, a stainless steel ring of the type used in conventional wafer saw operations can be employed for frame 210. However, both pad 220 and frame 210 can be implemented in many different ways as well. For example, frame 210 can be constructed from any rigid material compatible with the IC package assembly process, such as copper, aluminum, or even non-metals such as ceramic or plastic. Also, while depicted as a

thin circular element, frame 210 can also take a variety of configurations depending on handling, interface, and user requirements. For instance, frame 210 can include positioning features to ensure consistent alignment for lead frame panel 110 and adhesive pad 220. A circular outline for frame 210 provides compatibility with conventional handling requirements for IC production, but is not a required aspect of the present invention.

Similarly, numerous implementations of adhesive pad 220 are possible. Any material compatible with the IC package assembly process and capable of providing the necessary support to the lead frame panel and IC chips can be used. The sticky tape mentioned previously is a convenient choice due to widespread current usage and availability. The use of one-sided sticky tape enables pad 220 to be applied to the bottom surface of frame 210 and provide an adhesive surface for mounting of lead frame panel 110, without requiring additional attachment materials or components. Pad 220 can also be patterned by removing selected portions in order to facilitate subsequent assembly operations such as electrical interconnection formation. Removal of pad 220 once packaging is complete can be performed in various ways, depending on the nature of the adhesive material used. A light adhesive material may allow pad 220 to simply be peeled away from frame 110. An alternative bonding agent requires exposure to UV light before removal of pad 220 can take place.

Figs. 3a and 3b show a graphical flow chart illustrating a method for manufacturing a lead frame BGA package using an embodiment of the present invention. The manufacturing process is described in conjunction with the elements described in Figs. 2a-2c. In a step 310 in Fig. 3a, adhesive pad 220 is applied to rigid frame 210 to create support fixture 200. Lead frame panel 110 is then mounted on pad 220 in a step 320. An optional step 330 allows encapsulant dam 240 to be applied around the border of lead frame panel 110 if subsequent encapsulant material dispensing is to be performed. Next, an IC chip 130 is mounted and wire bonded onto each of the lead frames 120 of lead frame panel 110. Continuing the process in Fig. 3b, a step 350 involves dispensing a portion of encapsulant material 170 into the area defined by dam 240 to cover IC chips 130, and then curing material 170 to a desired hardness. In a step 360, pad 220 is removed from lead frame panel 110. Next, in a step 370, a wafer saw operation is performed to singulate lead frame panel 110 into individual IC packages. The singulation process converts the layer of hardened encapsulant material 170 into individual protective casings 160. Finally, in a step



380, solder balls 150 are applied to desired electrical interconnection locations to complete lead frame BGA IC package 190.

In this manner a lead frame BGA IC package can be produced using a temporary support structure. This enables the production of IC packages using lead frames that would otherwise be too fragile to withstand conventional manufacturing processes. It should be noted that while particular embodiments of the present invention have been shown and described, it will be apparent to those skilled in the art that many modifications and variations thereto are possible, all of which fall within the true spirit and scope of the invention. For example, the wafer saw operation of step 370 can be performed prior to removal of support fixture 200 from lead frame panel 110. Also, solder balls 150 could be applied to lead frames 120 in step 370 prior to singulation. Alternatively, appropriately located openings in adhesive pad 220 would allow solder balls 150 to be applied without removing pad 220. Certain lead frame designs may even allow patterning of pad 220 such that removal is unnecessary. Finally, while the present invention has been described with reference to chip scale IC package manufacturing, it can be applied to any IC package manufacturing, process involving lead frames, including non-chip scale and non-BGA IC packages such as SOP's, PLCC's, and PTH packages.

## ABSTRACT

In one aspect of the invention, a lead frame panel suitable for use in packaging an array of integrated circuits is described. The lead frame panel includes a matrix of tie bars that extend in substantially perpendicular rows and columns to define a two dimensional array of immediately adjacent device areas separated only by the tie bars. Each device area is suitable for use in an independent integrated circuit package and includes a die attach pad and a plurality of conductive contacts. In another aspect of the invention, a panel assembly suitable for use in simultaneously packaging a multiplicity of integrated circuits is described. The panel assembly includes a lead frame panel formed from a conductive sheet. The lead frame panel is patterned to define at least one two dimensional array of adjacent device areas. Each device area is suitable for use as part of an independent integrated circuit package and including a die and a plurality of contacts positioned around and electrically connected to the die. A molded cap is also provided that substantially uniformly covers a two dimensional array of adjacent device areas while leaving bottom surfaces of the conductive contacts exposed to facilitate electrical connection to external components. The encapsulation material that forms the molded cap is exposed at a bottom surface of the panel of integrated circuits to physically isolate the contacts.

~~A method for producing chip scale IC packages includes the step of mounting a lead frame panel on a temporary support fixture in order to provide support and protection during the manufacturing process. An embodiment of the temporary support fixture includes a sheet of sticky tape secured to a rigid frame. The rigid frame maintains tension in the sheet of sticky tape to provide a stable surface to which the lead frame panel can be affixed. Installation of IC chips and encapsulation in protective casings is performed as in conventional IC package manufacturing. If encapsulant material is to be dispensed over the IC chips, an encapsulant dam can be formed around the lead frame panel to contain the flow of encapsulant material. The temporary support fixture can be used in any IC package manufacturing process in which lead frames require supplemental support.~~